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Alpha & Omega Semiconductor, Ltd.

AOD403

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC I	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V	-30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-24V, V _{GS} =0V T _J =55°C		-0.01	-1	μA
					-5	
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±25V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} I _D =-250μA	-1.5	-2.6	-3.5	V
I _{D(ON)}	On state drain current	V _{GS} =-10V, V _{DS} =-5V	-60			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-20V, I _D =-20A		5.1	6	mΩ
		T _J =125°C		7.1	8.5	
		V _{GS} =-10V, I _D =-20A		6.3	7.6	mΩ
g fs	Forward Transconductance	V _{DS} =-5V, I _D =-20A		44		S
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V		-0.72	-1	V
I _S	Maximum Body-Diode Continuous Current				-104	Α
DYNAMI	C PARAMETERS					
C _{iss}	Input Capacitance			4360	5300	pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =-15V, f=1MHz		1050		pF
C _{rss}	Reverse Transfer Capacitance			762		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2.5	3	Ω
SWITCHI	NG PARAMETERS					
Qg	Total Gate Charge			93.2	120	nC
Q_gs	Gate Source Charge	V_{GS} =-10V, V_{DS} =-15V, I_{D} =-20A		18		nC
Q_{gd}	Gate Drain Charge			29.2		nC
t _{D(on)}	Turn-On DelayTime			18	25	ns
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-15V, R_L =0.75 Ω ,		30	45	ns
t _{D(off)}	Turn-Off DelayTime	R_{GEN} =3 Ω		51	75	ns
t _f	Turn-Off Fall Time			35	50	ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-20A, dI/dt=100A/μs		39.5	48	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-20A, dI/dt=100A/μs		30.8	37	nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C. The Power dissipation P_{DSM} is based on steady-state $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB or heatsink allows it.

B. The power dissipation P_D is based on $T_{J(MAX)}=175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

C: Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}\text{=}175\,^\circ\text{C}.$

D. The R $_{\text{BJA}}$ is the sum of the thermal impedence from junction to case R_{BJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

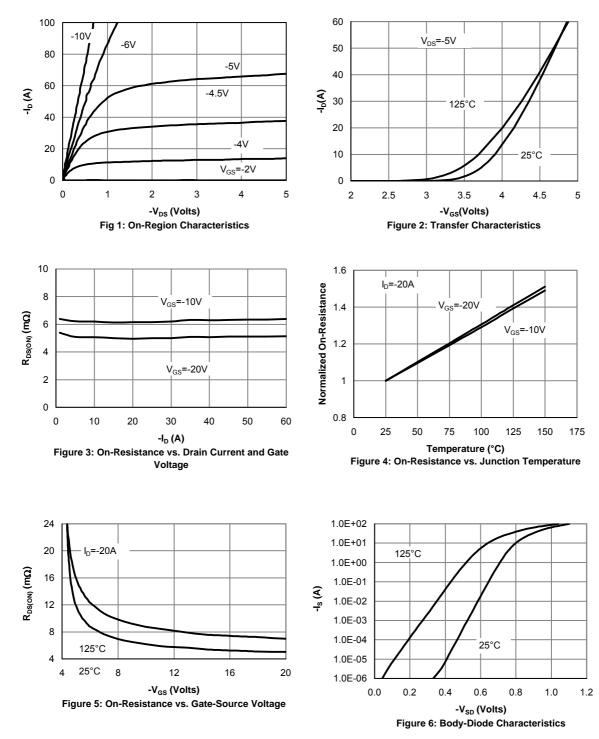
F. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C. The SOA curve provides a single pulse rating.

G. The maximum current rating is limited by the package current capability.

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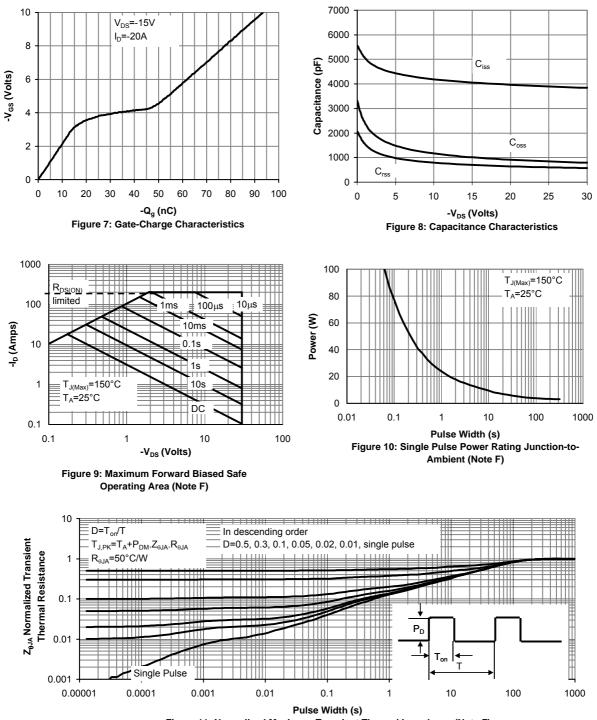
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